

Application/Control No.	

Applicant(s)/Patent under Reexamination HEUER, VOLKMAR

09/899,984

Art Unit

Examiner

John L. Shew

2664

SEARCHED					
Class	Subclass	Date	Examiner		
370	217,218	8/22/2005	JS		
	222,223				
	225,237				
	353-355				
	390				
	395.21				
	404-406				
	452				
398	2-4	8/22/2005	JS		
	12,45				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
370	223	8/23/2005	JS		
370	405	8/23/2005	JS		
398	4	8/23/2005	JS		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	